MOSFET – SiC Power, Single N-Channel, D2PAK-7L 650 V, 31 mΩ, 62 A

NTBG045N065SC1

Features

- Typ. $R_{DS(on)} = 31 \text{ m}\Omega$ @ $V_{GS} = 18 \text{ V}$ Typ. $R_{DS(on)} = 45 \text{ m}\Omega$ @ $V_{GS} = 15 \text{ V}$
- Ultra Low Gate Charge (Q_{G(tot)} = 105 nC)
- Low Effective Output Capacitance (Coss = 168 pF)
- 100% Avalanche Tested
- $T_J = 175^{\circ}C$
- RoHS Compliant

Typical Applications

- SMPS (Switching Mode Power Supplies)
- Solar Inverters
- UPS (Uninterruptable Powere Supplies)
- Energy Storages

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	650	V
Gate-to-Source Voltage	ge		V_{GS}	-8/+22	V
	Recommended Operation Values of Gate – Source Voltage T _C < 175°C			-5/+18	V
Continuous Drain Current (Note 2)	Steady	Steady T 050C		62	Α
Power Dissipation (Note 2)	State	State T _C = 25°C	P _D	242	W
Continuous Drain Current (Notes 1, 2)	Steady	T _C = 100°C	I _D	44	Α
Power Dissipation (Notes 1, 2)	State	10 - 100 0	P _D	121	W
Pulsed Drain Current (Pulsed Drain Current (Note 3) T _C = 25°C			184	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			I _S	56	Α
Single Pulse Drain-to-Source Avalanche Energy (I _L = 12 A _{pk} , L = 1 mH) (Note 4)			E _{AS}	72	mJ
Maximum Lead Temperature for Soldering, 1/8" from Case for 10 Seconds			TL	245	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

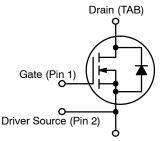
- 1. Surface mounted on a FR-4 board using1 in2 pad of 2 oz copper.
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 3. Repetitive rating, limited by max junction temperature.
- 4. E_{AS} of 72 mJ is based on starting T_J = 25°C; L = 1 mH, I_{AS} = 12 A, V_{DD} = 50 V, V_{GS} = 18 V.



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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
650 V	50 mΩ @ 18 V	62 A	



Power Source (Pins 3, 4, 5, 6, 7)

N-CHANNEL MOSFET



D2PAK-7L CASE 418BJ

MARKING DIAGRAM

BG045N 065SC1 AYWWZZ

BG045N065SC1 = Specific Device Code

A = Assembly Location

Y = Year WW = Work Week ZZ = Lot Traceability

ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

THERMAL CHARACTERISTICS

Parameter	Symbol	Max	Units
Junction-to-Case - Steady State (Note 2)	$R_{ heta JC}$	0.62	°C/W
Junction-to-Ambient - Steady State (Notes 1, 2)	$R_{ heta JA}$	40	°C/W

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					I.	<u>I</u>	l
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0	V, I _D = 1 mA	650	_	_	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = 20 mA, refer to 25°C		-	0.13	_	V/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V	T _J = 25°C	-	_	10	μΑ
		V _{DS} = 650 V	T _J = 175°C	-	_	1	mA
Gate-to-Source Leakage Current	I _{GSS}	V _{GS} = +18/-	-5 V, V _{DS} = 0 V	-	_	250	nA
ON CHARACTERISTICS					•	•	•
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{D}$	_S , I _D = 8 mA	1.8	2.8	4.3	V
Recommended Gate Voltage	V_{GOP}			-5	_	+18	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 15 V, I _D	= 25 A, T _J = 25°C	-	45	_	mΩ
		V _{GS} = 18 V, I _D	= 25 A, T _J = 25°C	-	31	50	
		V _{GS} = 18 V, I _D =	= 25 A, T _J = 175°C	-	40	_	
Forward Transconductance	9 _{FS}	V _{DS} = 10	V, I _D = 25 A	-	16	_	S
CHARGES, CAPACITANCES & GATE RESI	STANCE				-	•	
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 325 V		-	1890	_	pF
Output Capacitance	C _{OSS}			-	168	_	
Reverse Transfer Capacitance	C _{RSS}			-	15	_	
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = -5/18 \text{ V}, V_{DS} = 520 \text{ V},$ $I_{D} = 25 \text{ A}$		-	105	_	nC
Gate-to-Source Charge	Q _{GS}			-	27	_	
Gate-to-Drain Charge	Q_{GD}			-	30	_	
Gate-Resistance	R _G	f = 1 MHz		-	3.1	_	Ω
SWITCHING CHARACTERISTICS					I		
Turn-On Delay Time	t _{d(ON)}			-	13	_	ns
Rise Time	t _r			-	14	_	
Turn-Off Delay Time	t _{d(OFF)}	V 5/10	V V - 400 V	-	26	_	
Fall Time	t _f	$I_{D} = 25 A$	$V, V_{DS} = 400 V,$ $R_{G} = 2.2 \Omega,$	-	7	_	
Turn-On Switching Loss	E _{ON}	Induc	tive Load	-	47	_	μJ
Turn-Off Switching Loss	E _{OFF}			-	33	_	
Total Switching Loss	E _{TOT}			-	80	_	
SOURCE-DRAIN DIODE CHARACTERISTI	CS						
Continuous Source-Drain Diode Forward Current	I _{SD}	V _{GS} = -5	V, T _J = 25°C	-	-	56	А
Pulsed Source–Drain Diode Forward Current (Note 3)	I _{SDM}	V _{GS} = -5 V, T _J = 25°C		-	-	184	А
Forward Diode Voltage	V _{SD}	$V_{GS} = -5 \text{ V}, I_{SD}$	₀ = 25 A, T _J = 25°C	-	4.4	_	V

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise stated)

Parameter	Symbol Test Condition		Min	Тур	Max	Unit	
SOURCE-DRAIN DIODE CHARACTERISTICS							
Reverse Recovery Time	t _{RR}		-	20	_	ns	
Reverse Recovery Charge	Q _{RR}	V _{GS} = -5/18 V, I _{SD} = 25 A, dI _S /dt = 1000 A/μs	-	100	-	nC	
Reverse Recovery Energy	E _{REC}		-	3.8	-	μJ	
Peak Reverse Recovery Current	I _{RRM}		-	10	-	Α	
Charge time	Ta		-	11	-	ns	
Discharge time	Tb	1	-	8.7	_	ns	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

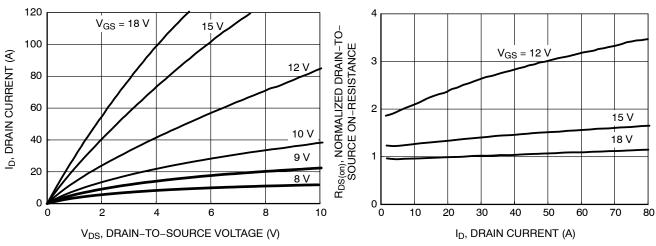


Figure 1. On-Region Characteristics

Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

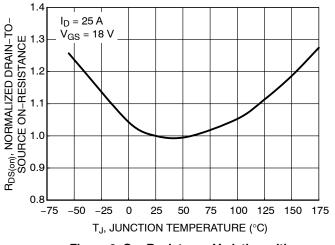


Figure 3. On–Resistance Variation with Temperature

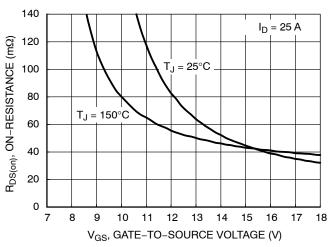


Figure 4. On-Resistance vs. Gate-to-Source Voltage

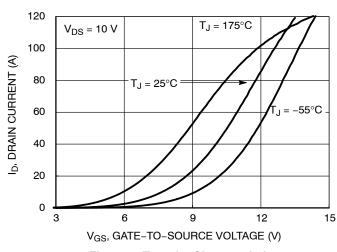


Figure 5. Transfer Characteristics

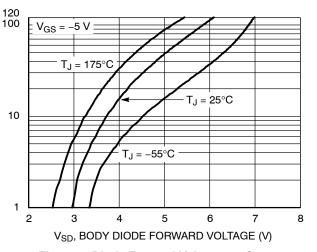


Figure 6. Diode Forward Voltage vs. Current

REVERSE DRAIN CURRENT (A)

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TYPICAL CHARACTERISTICS

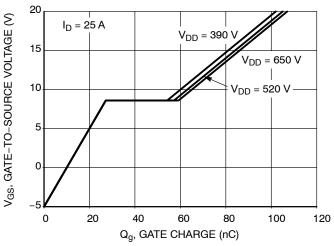


Figure 7. Gate-to-Source Voltage vs. Total Charge

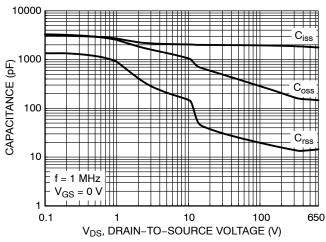


Figure 8. Capacitance vs. Drain-to-Source Voltage

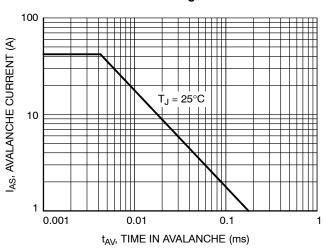
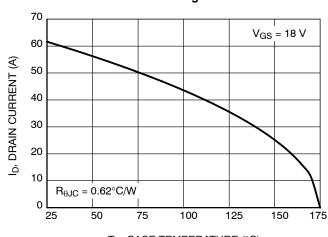


Figure 9. Unclamped Inductive Switching Capability



T_C, CASE TEMPERATURE (°C)

Figure 10. Maximum Continuous Drain Current vs. Case Temperature

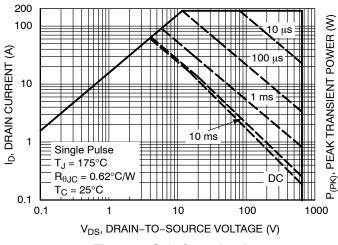


Figure 11. Safe Operating Area

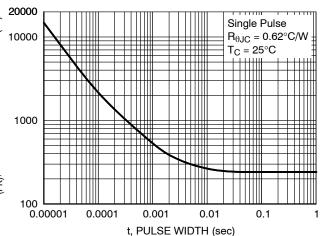


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS

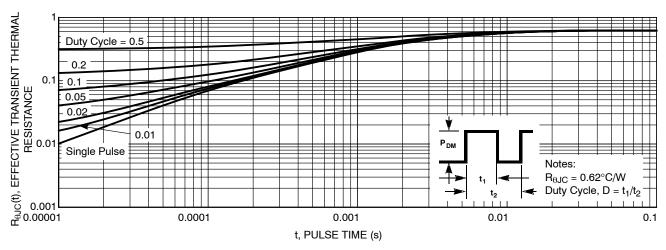


Figure 13. Junction-to-Case Transient Thermal Response

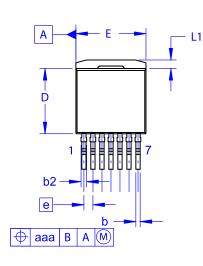
DEVICE ORDERING INFORMATION

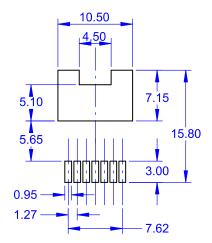
Device	Package	Shipping [†]
NTBG045N065SC1	D2PAK-7L	800 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

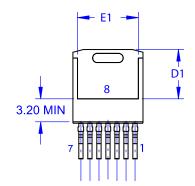
PACKAGE DIMENSIONS

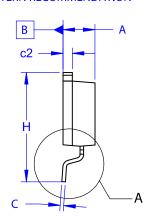
D²PAK7 (TO-263-7L HV) CASE 418BJ **ISSUE B**





LAND PATTERN RECOMMENDATION





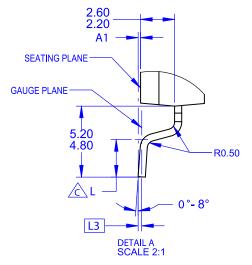
NOTES:

- A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.
- OUT OF JEDEC STANDARD VALUE.

 D. DIMENSION AND TOLERANCE AS PER ASME
 Y14.5-2009.

 E. DIMENSIONS ARE EXCLUSIVE OF BURRS,
 MOLD FLASH AND TIE BAR PROTRUSIONS.

DIM	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	4.30	4.50	4.70		
A1	0.00	0.10	0.20		
b2	0.60	0.70	0.80		
b	0.51	0.60	0.70		
С	0.40	0.50	0.60		
c2	1.20	1.30	1.40		
D	9.00	9.20	9.40		
D1	6.15	6.80	7.15		
Е	9.70	9.90	10.20		
E1	7.15	7.65	8.15		
е	~	1.27	~		
Н	15.10	15.40	15.70		
L	2.44	2.64	2.84		
L1	1.00	1.20	1.40		
L3	~	0.25	~		
aaa	~	~	0.25		



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